Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/701,321	KIM, JOUNG-YEAL	
Examiner	Art Unit	
Anh Q. Tran	2819	

	SEAR	CHED	
Class	Subclass	Date	Examiner
326	26-27, 57- 58	8/15/2005	АТ
327	108, 112	8/15/2005	, AT
			1

INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	-L			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search-see printout	8/16/2005	AT		